P21646.A04



Applicants : Yetik SERBEST et al.

Group Art Unit: 2663

Appln. No. : 10/015,809

Examiner:

Filed: December 17, 2001

For : SYSTEM AND METHOD FOR MEASUREMENT-BASED ADAPTIVE

**CACHING OF VIRTUAL CONNECTIONS** 

## SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents Alexandria, Virginia 22313-1450 RECEIVED

FEB 1 3 2004

Sir:

Technology Center 2600

In accordance with the duty of disclosure under 37 C.F.R. §1.56, §1.97-1.98, Applicants hereby call the following documents to the Examiner's attention:

The following references were cited in a Canadian Office Action dated August 27, 2002 for Canadian Patent Application No. 2,299,438;

USP 6,101,183 to BYERS, issued on August 08, 2000;

USP 6,141,339 to KAPLAN et al., issued on October 31,2000;

Applicants respectfully request that the Examiner consider the above materials and cite the patent documents. All of the above-mentioned documents have been listed on a PTO-1449 Form which is also attached. Accordingly, the Examiner is requested to initial the appropriate spaces on the attached PTO-1449 Form and to return a copy of the Form to Applicants with the next official communication in the present application to confirm consideration of these documents.

## P21646.A04

Should the Examiner have any questions, the Examiner is invited to contact the undersigned at the below-listed telephone number.

Respectfully submitted,

Yetik SERBEST et al.

Bruce H. Bernstein Reg. No. 29,027

February 12, 2004 GREENBLUM & BERNSTEIN, P.L.C. 1950 Roland Clarke Place Reston, VA 20191 (703) 716-1191

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Form PTO-1449

U.S. Department of Commerce Patent and Trademark Office

Atty. Docket No. TRADENA

Serial No. 10/015,809

## INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use several sheets if necessary)

Applicant Yetik SERBEST et al.

Filing Date Group
December 17, 2001 Group

## U.S. PATENT DOCUMENTS

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EXAMINER

DATE CONSIDERED

<sup>\*</sup>EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.